



# AGIPD Meeting @ PSI

31 Mar – 2 Apr 2014



## ➤ Optimization of the Bias Voltages (AGIPD05)

- $V_{ref,cob}$
- $V_{com,cob}$
- $V_{ref,pxb}$
- $(V_{ref,cds})$
- Influence of the Output CM on the linearity

## ➤ Data Acquisition with Photons (AGIPD10)

- Investigation of the impact of Writing Speed and  $V_{ref,cds}$  on the Pulse Height
- Noise

## ➤ Ongoing....

# Optimization of Reference Voltages

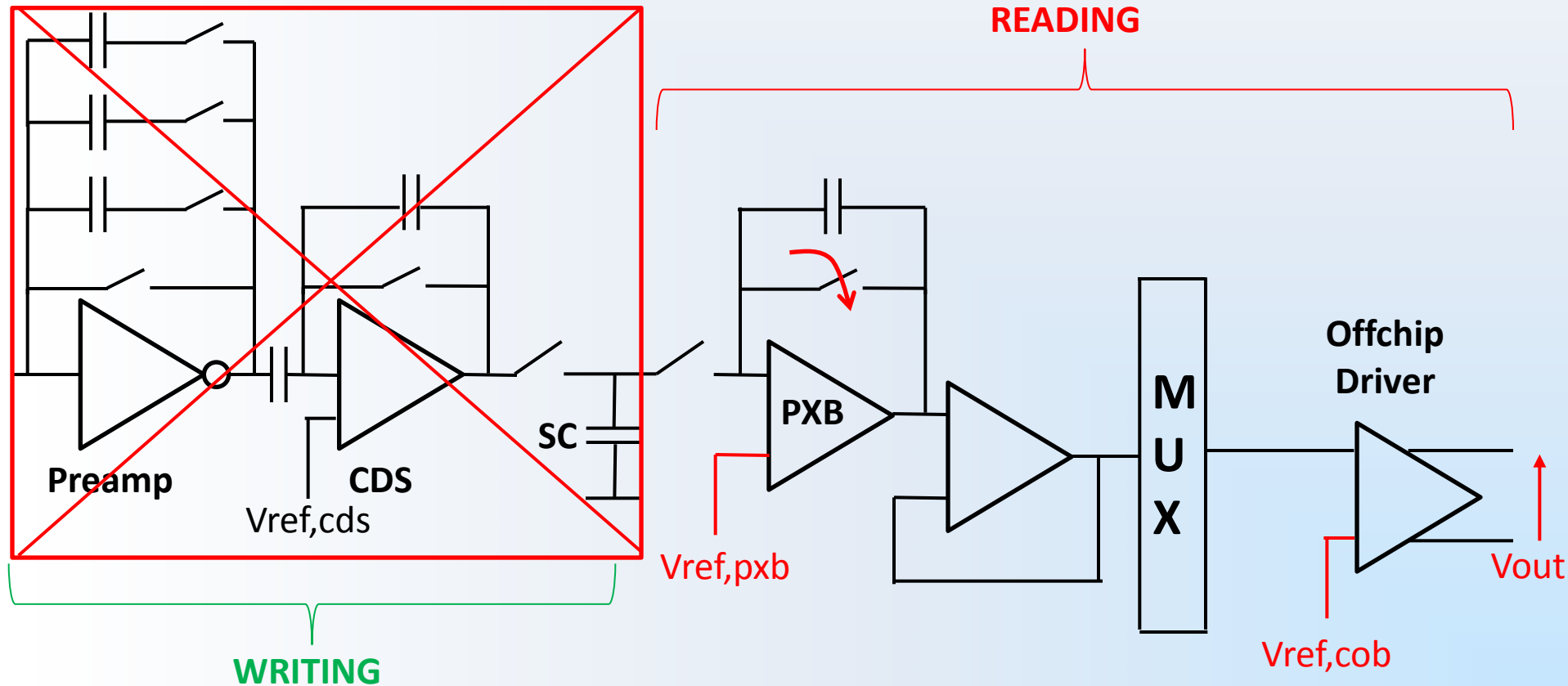


## Vref,cob

Measurements on AGIPD05, 1 Pixel (Same as AGIPD10)

Chip Running @ 80MHz

PXB **ALWAYS** in Reset -> Scan Over Vref,cob and Vref,pxb



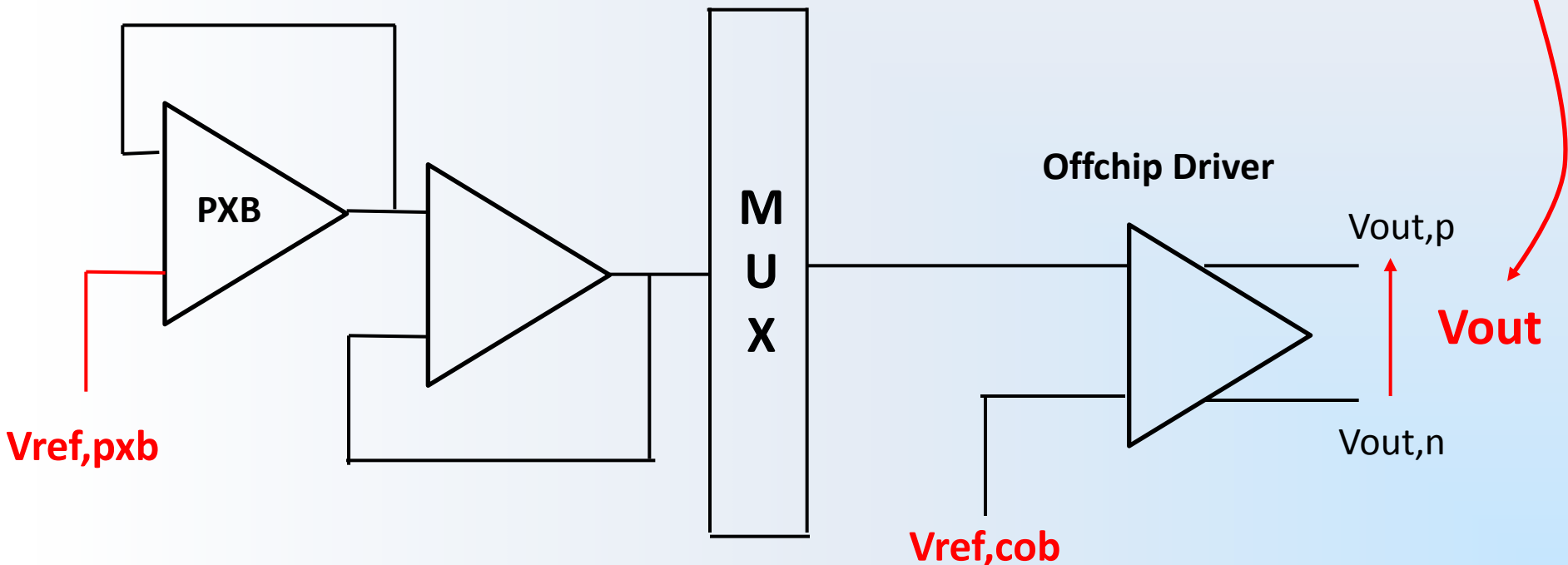
# Equivalent Scheme & Scan Settings



## Vref,pxb & Vref,cob Settings

Voltage step  $\Delta V = 33\text{mV}$   
Scan from 300 to 1300 mV

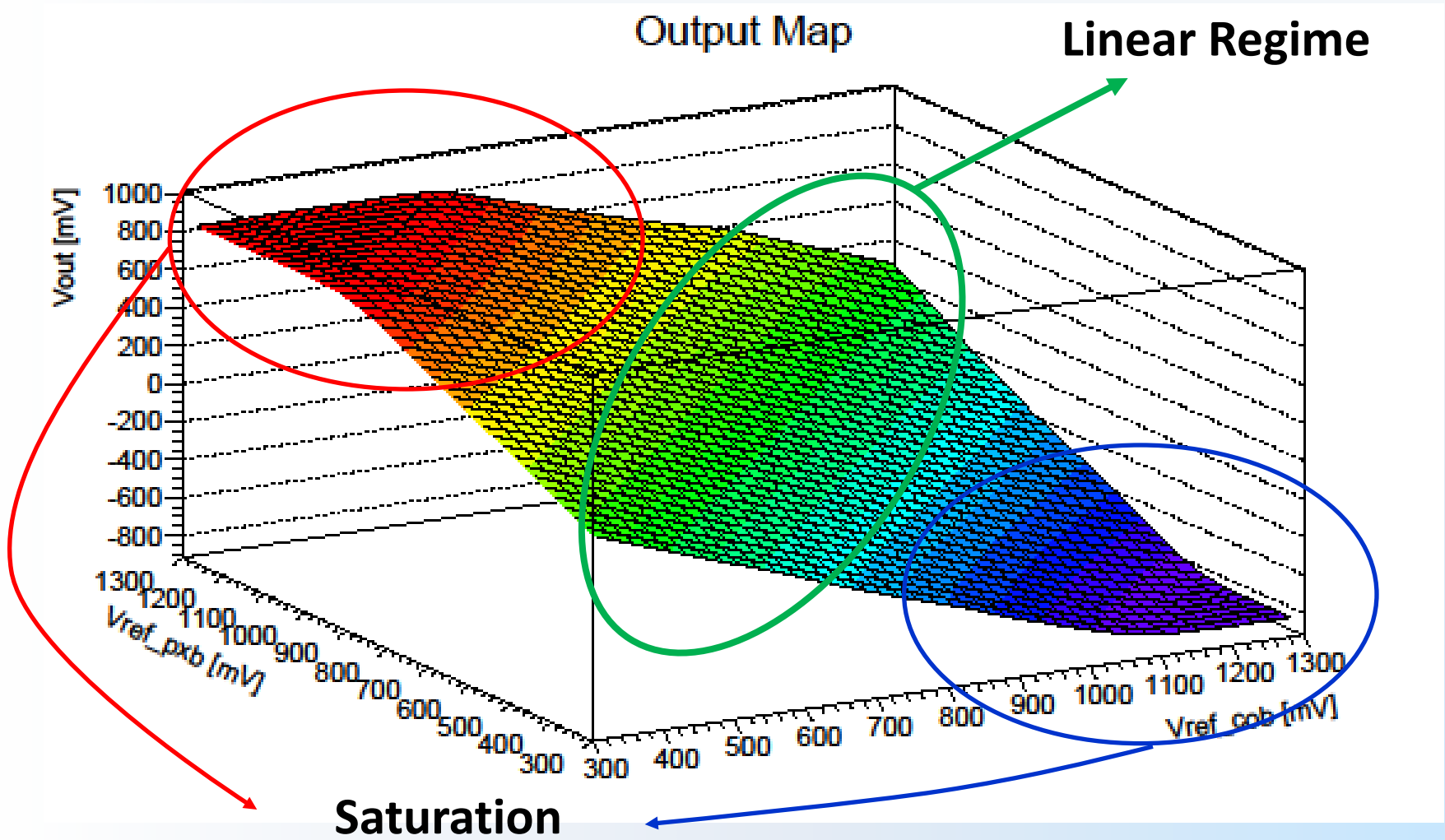
$$V_{out} = V_{out,p} - V_{out,n}$$



# 2D MAP



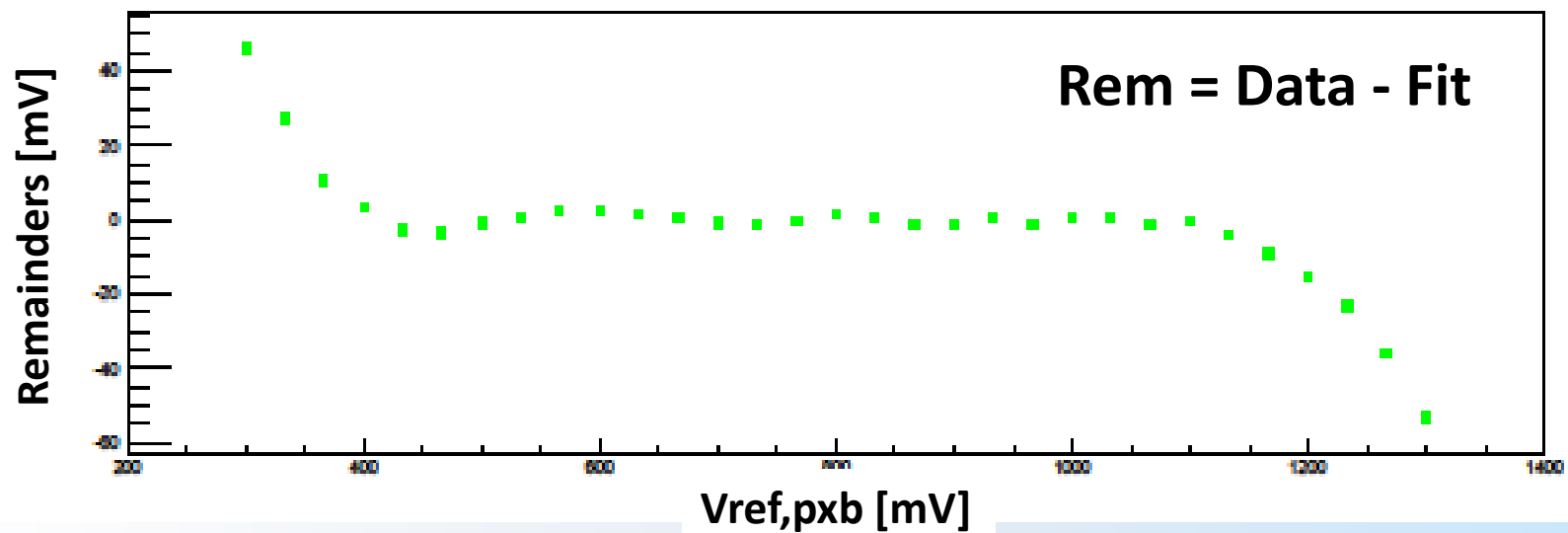
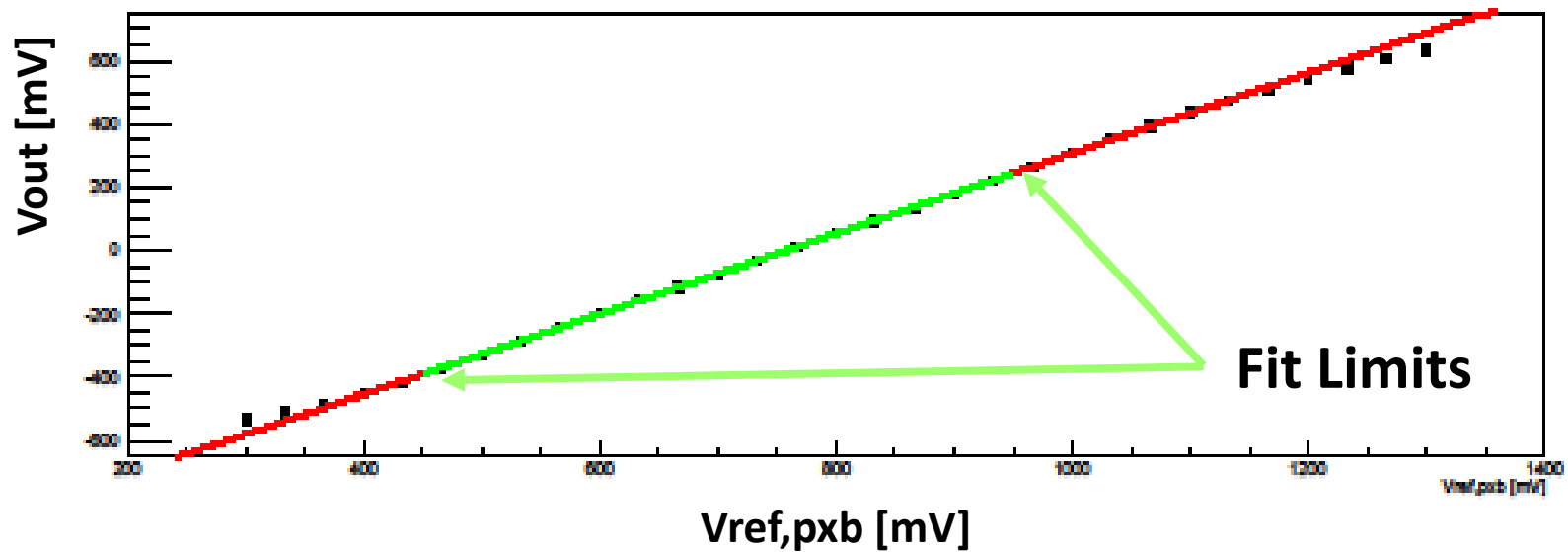
## Vref,cob and Vref,pxb



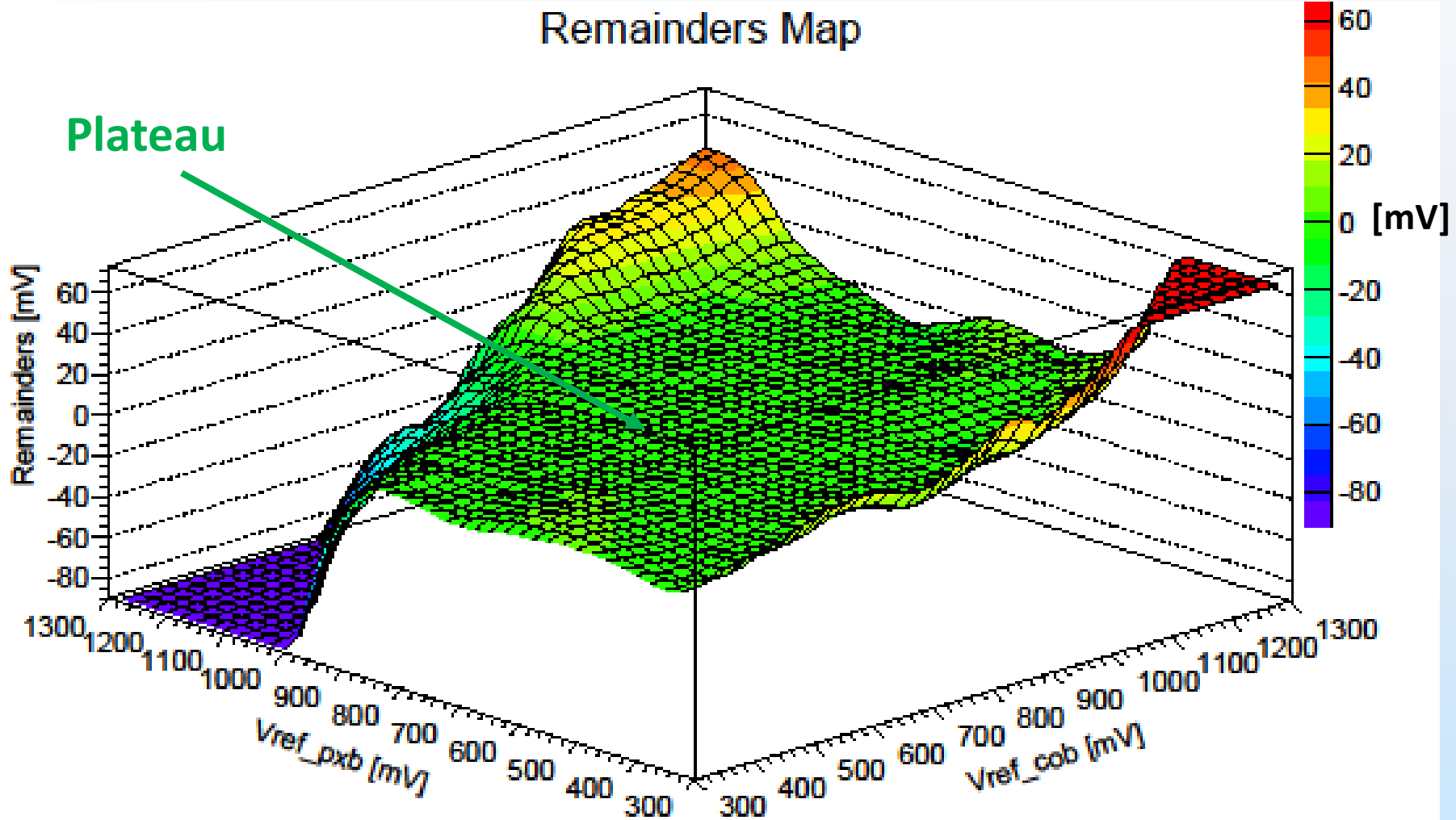
# SINGLE WFM AND FIT



Wfm #16, Fixed Vref,cob



# 3D REMAINDERS MAP



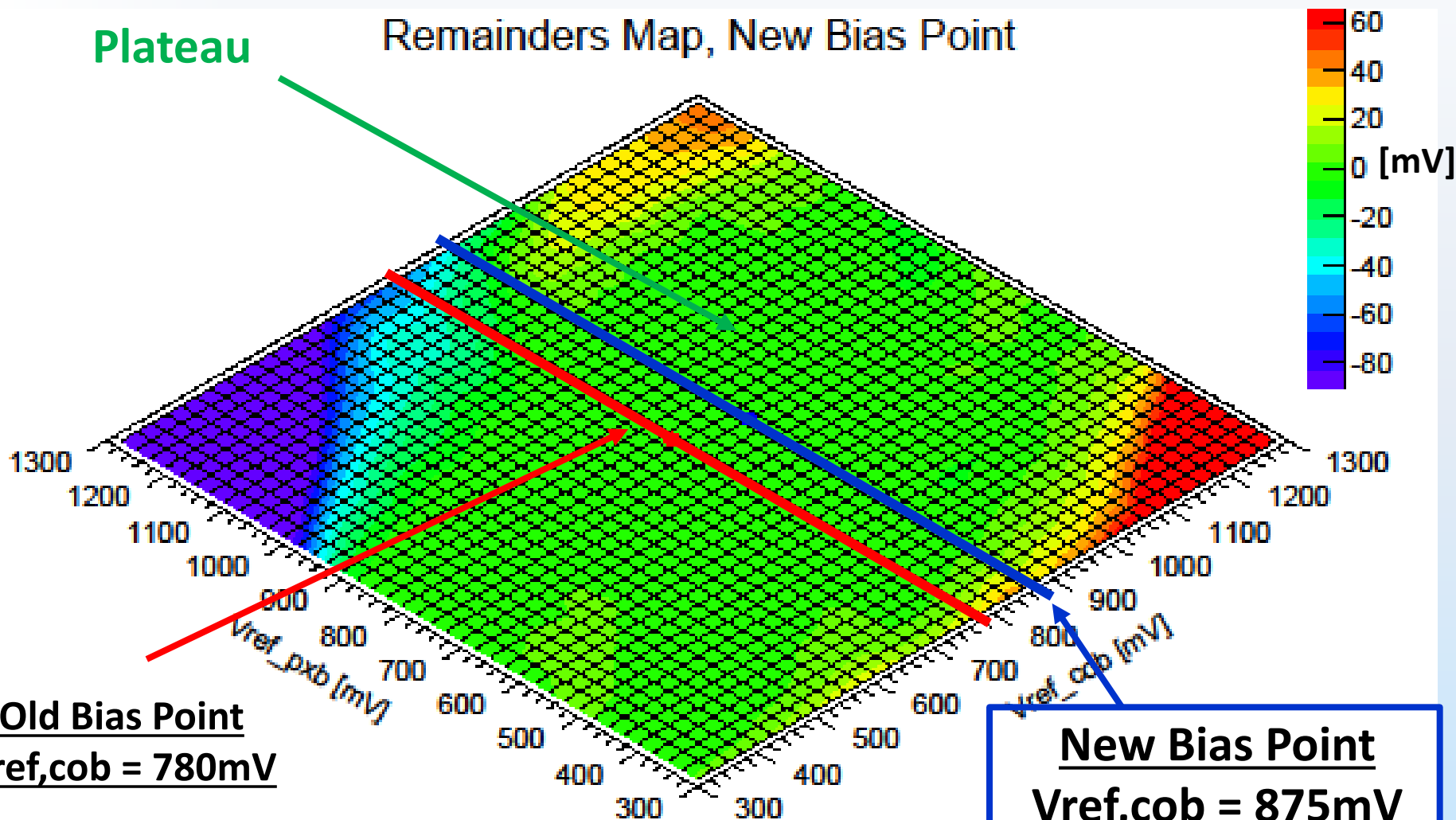
1 mV =  $64.7 \times 10^{-3}$  ph (@12keV), CDS gain high

# NEW BIAS POINT for $V_{ref,cob}$



Plateau

Remainders Map, New Bias Point



Old Bias Point

$V_{ref,cob} = 780$  mV

New Bias Point

$V_{ref,cob} = 875$  mV

1 mV =  $64.7 \times 10^{-3}$  ph (@12keV), CDS gain high



# Optimization of Reference Voltages

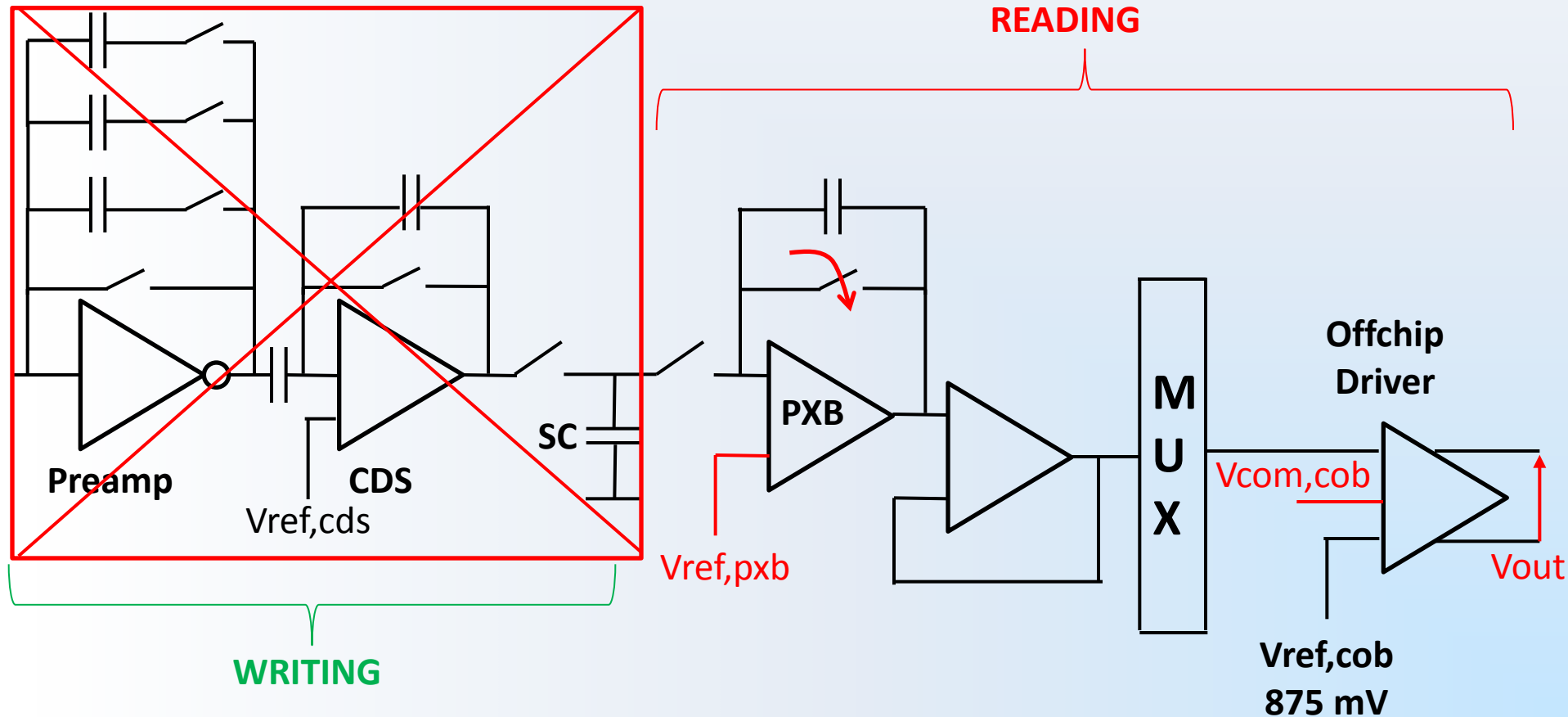


## Vcom,cob

Measurements on AGIPD05, 1 Pixel (Same as AGIPD10)

Chip Running @ 80MHz

PXB **ALWAYS** in Reset -> Scan Over Vcom,cob and Vref,pxb



# Equivalent Scheme & Scan Settings

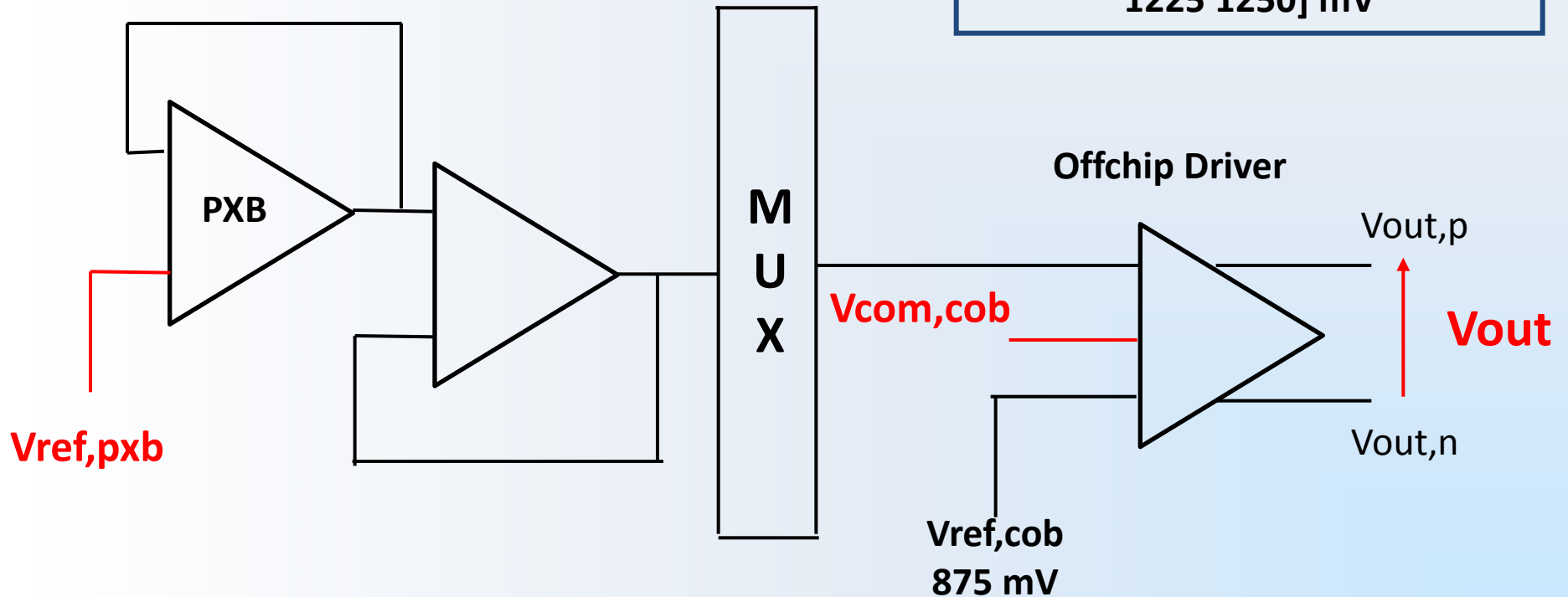


## Vref,pxb Settings

Voltage step  $\Delta V = 33\text{mV}$   
Scan from 300 to 1300 mV

## Vcom,cob Settings

Voltages Scanned  
[435 460 485 510 550 650 **750**  
850 950 1050 1150 1175 1200  
1225 1250] mV

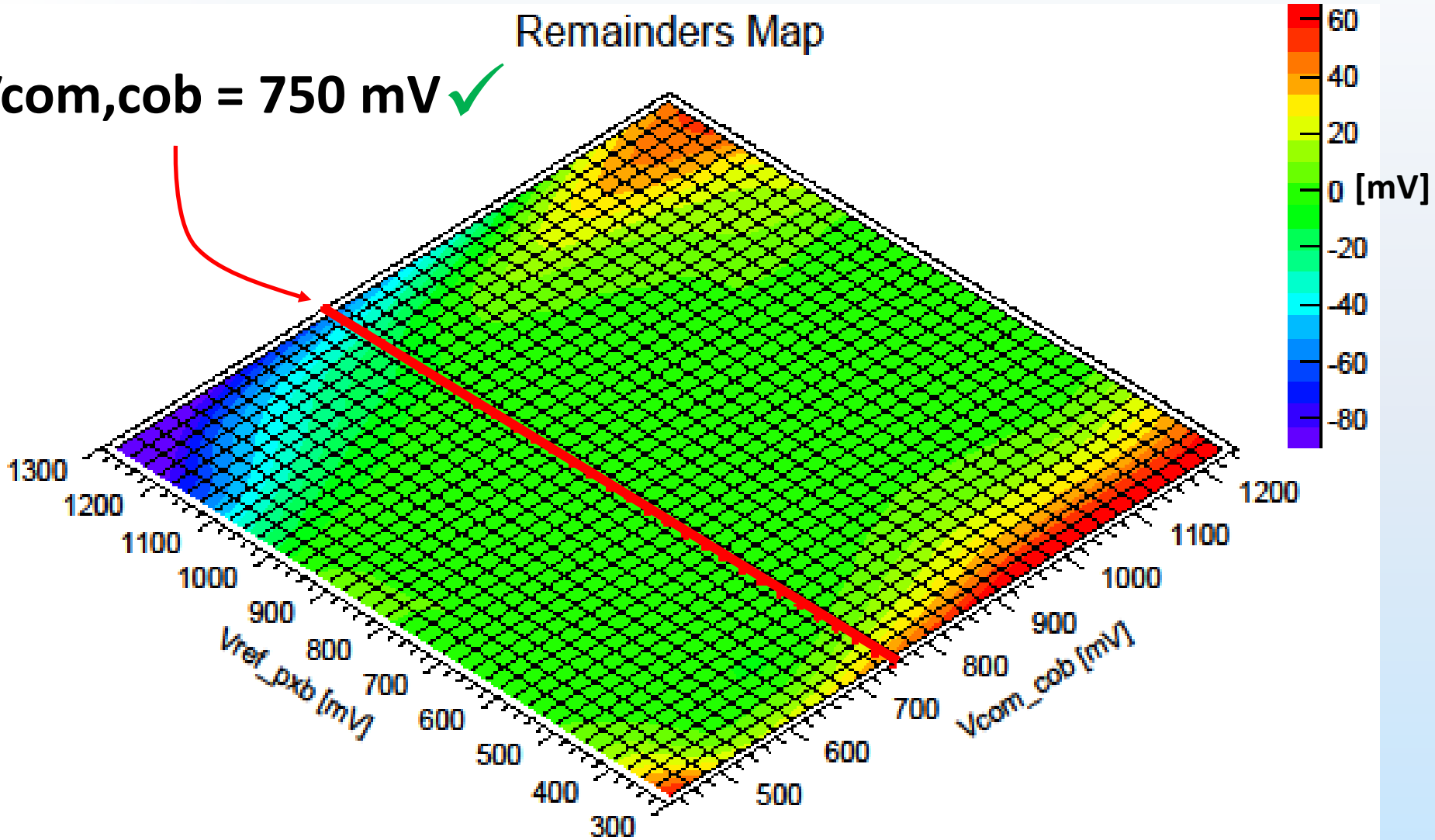


# BIAS POINT for $V_{com,cob}$



Remainders Map

$V_{com,cob} = 750 \text{ mV}$  ✓

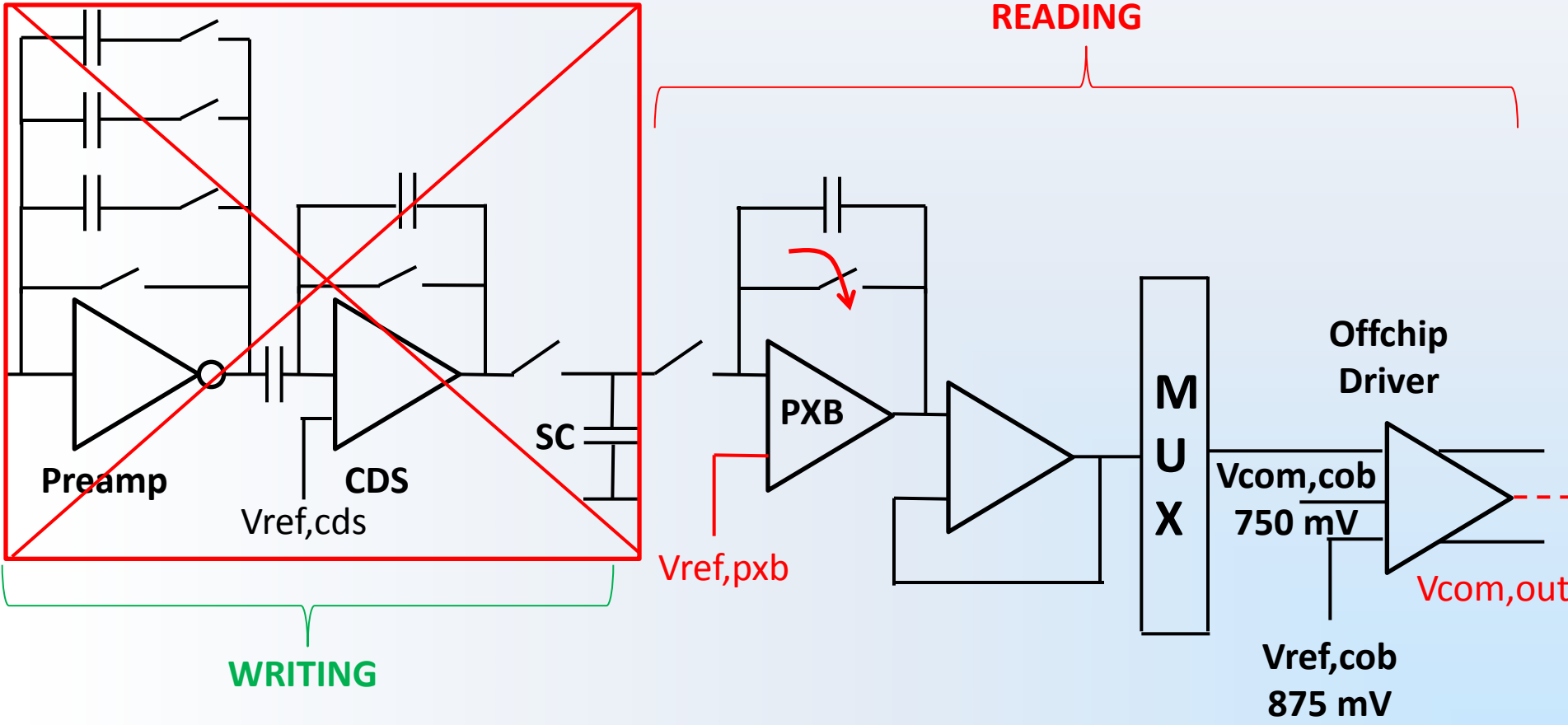


1 mV =  $64.7 \times 10^{-3}$  ph (@12keV), CDS gain high

# Output Common Mode (CM)



Investigating the Influence of Output CM on the linearity

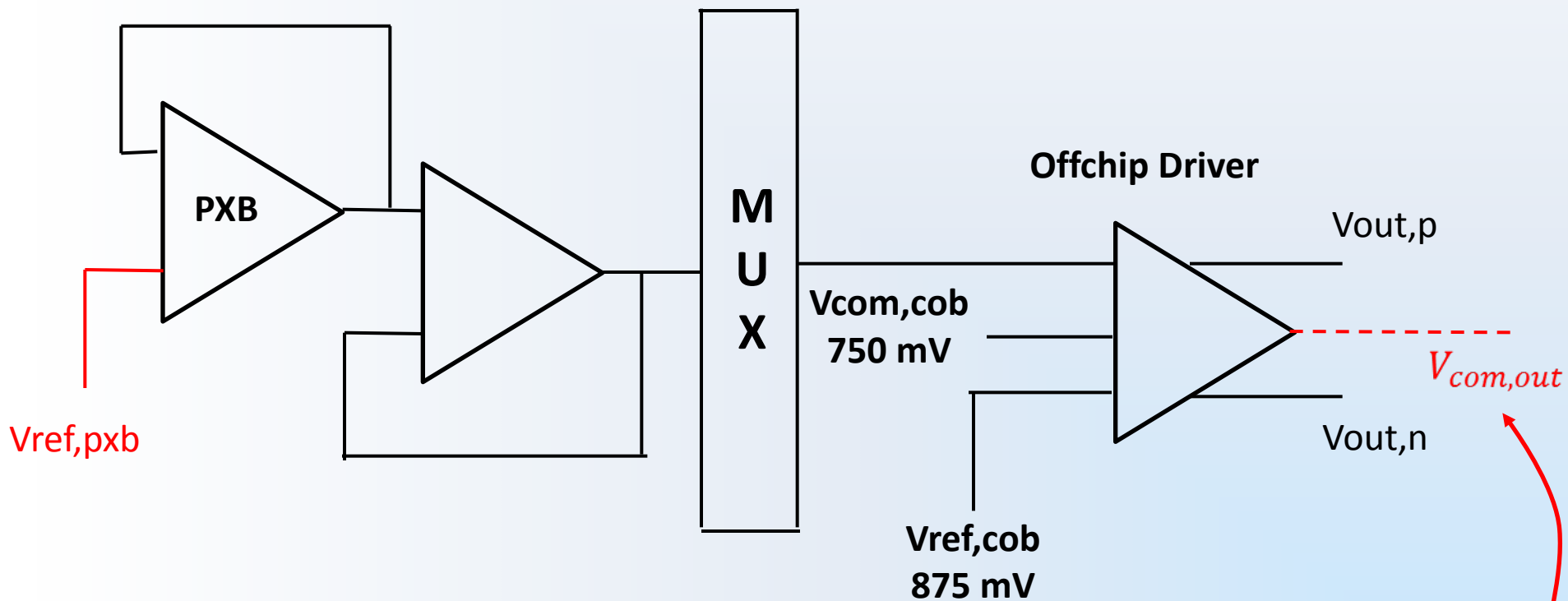


# Output Common Mode (CM)



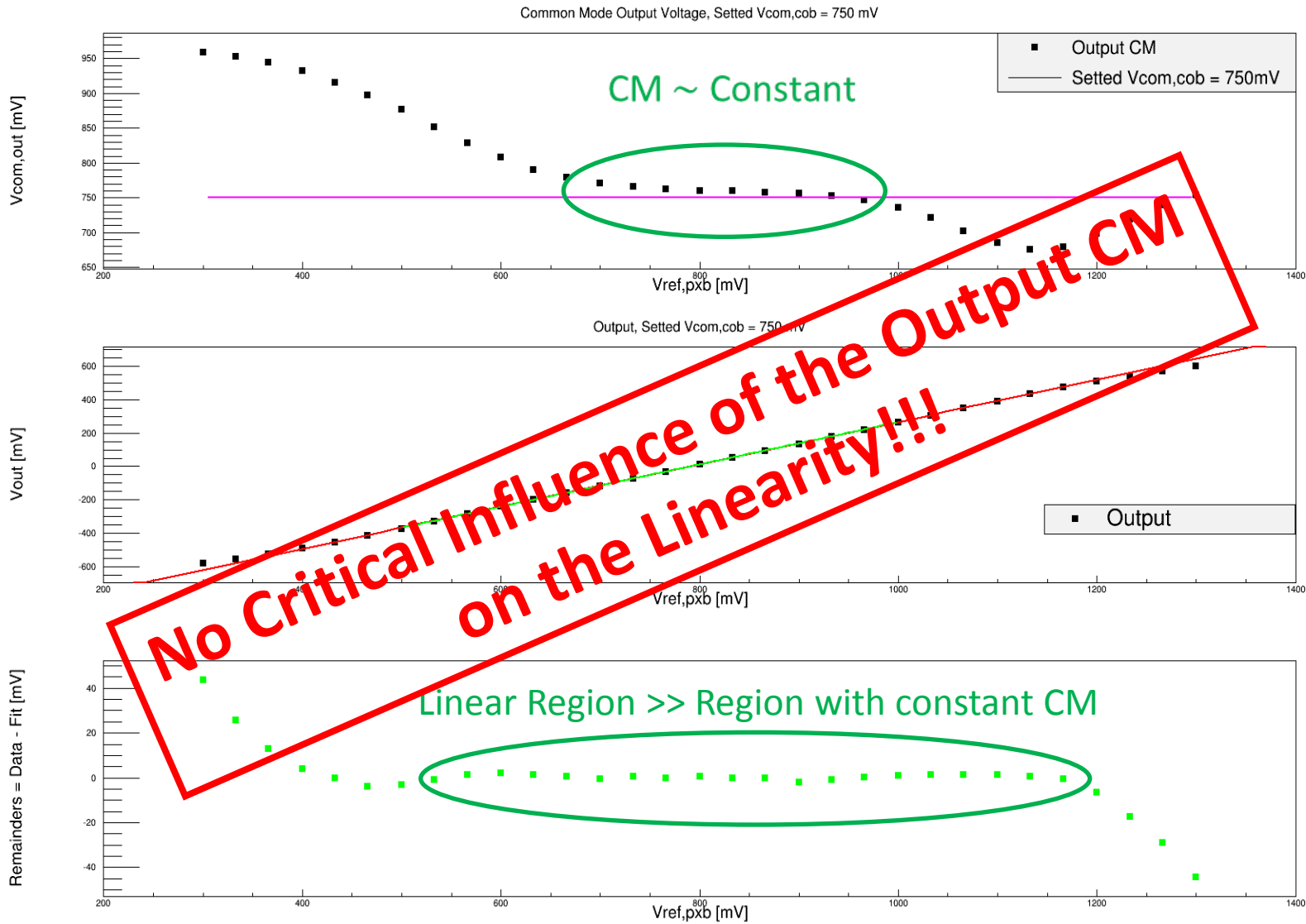
## Vref,pxb Settings

Voltage step  $\Delta V = 33\text{mV}$   
Scan from 300 to 1300 mV



$$V_{com,out} = \frac{V_{out,p} + V_{out,n}}{2}$$

# Output Common Mode (CM)



# Optimization of Reference Voltages



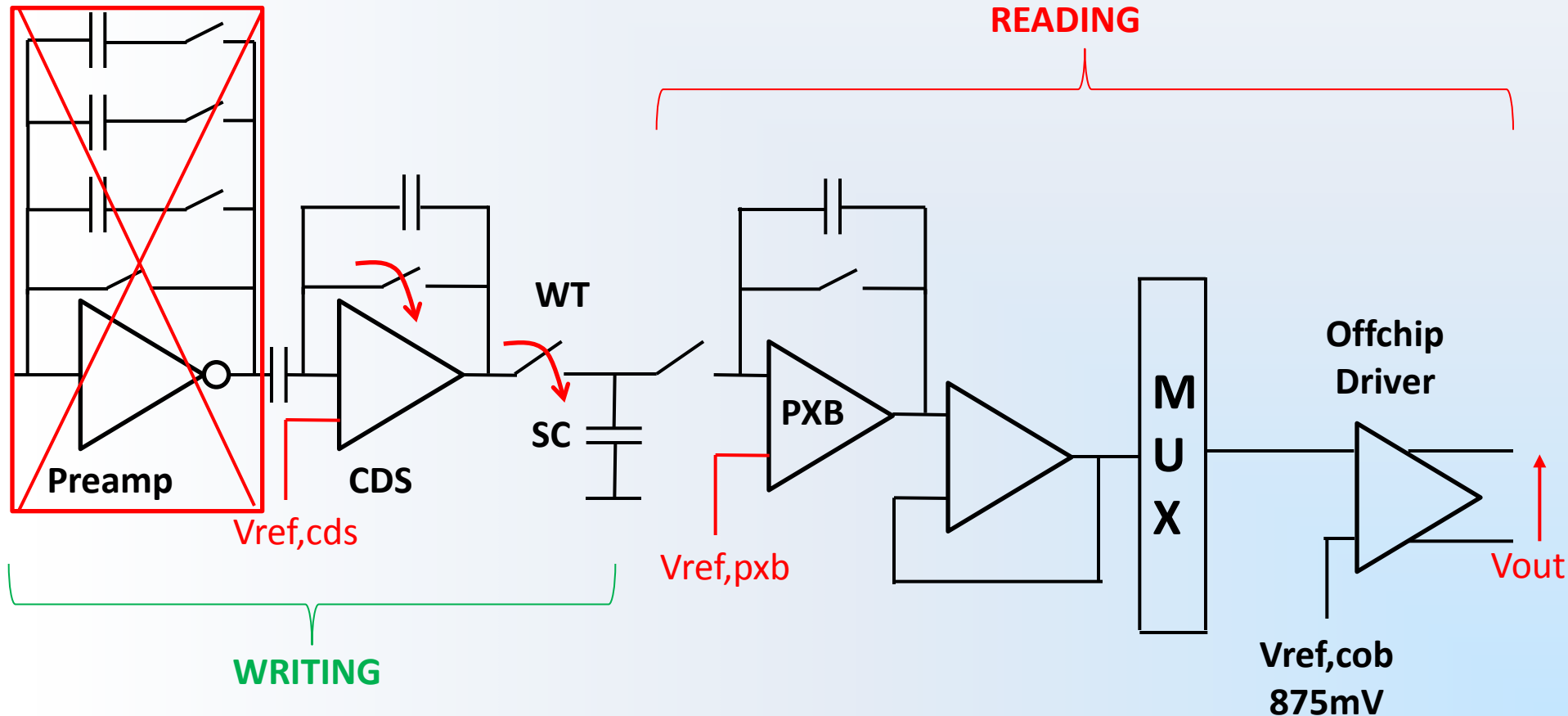
## Vref,pxb

Chip Running @ 80MHz

CDS ALWAYS in Reset.

Writing Time (WT) = 225ns

Voltage step  $\Delta V = 33\text{mV}$   
Scan from 300 to 1300 mV  
Both Vref,cds and Vref,pxb

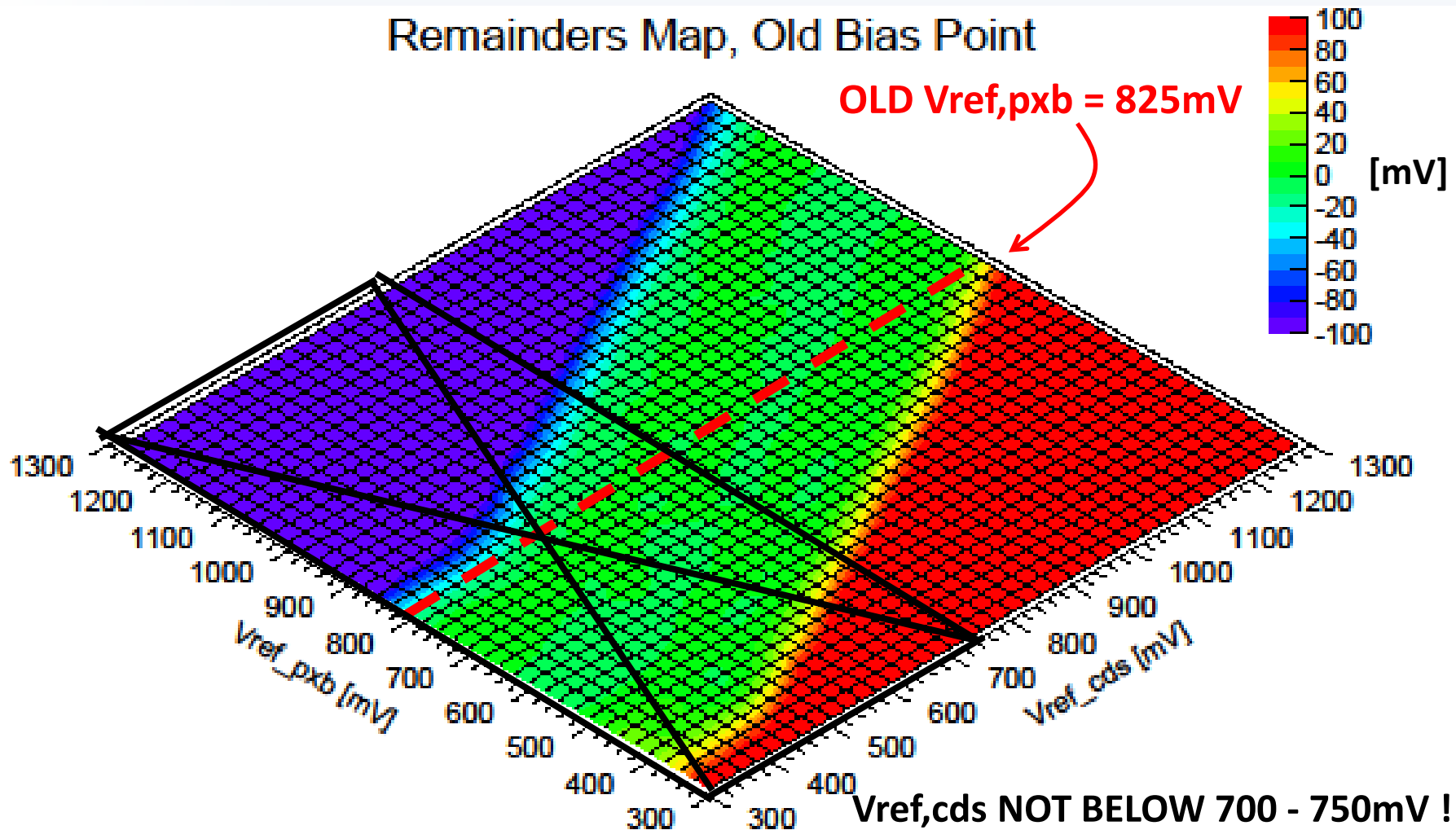


# Vref,pxb



## Remainders Map and Old Bias

Remainders Map, Old Bias Point



**Vref,cds NOT BELOW 700 - 750mV !!!**

1 mV =  $64.7 \times 10^{-3}$  ph (@12keV), CDS gain high

(See Next Slides!)

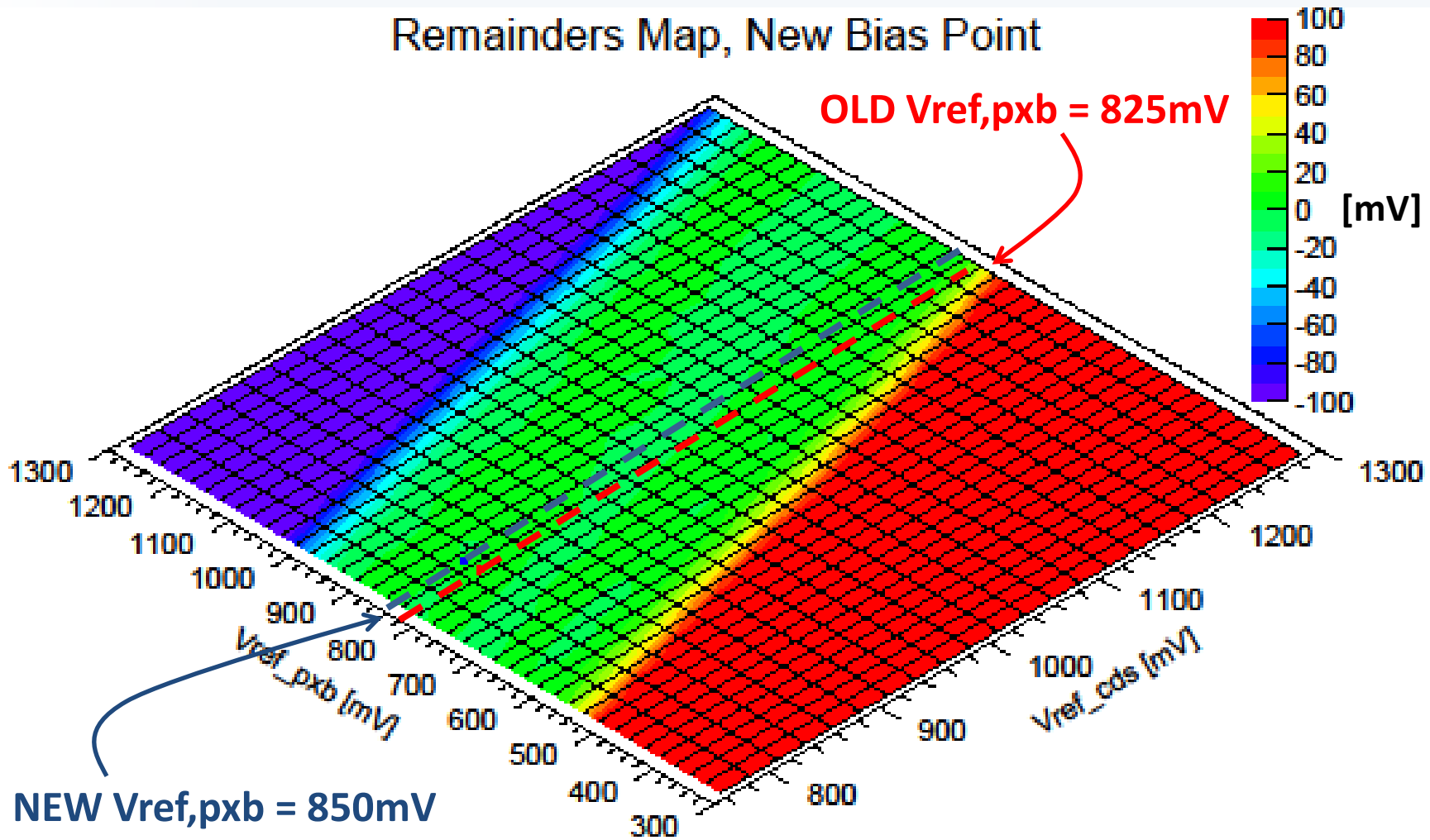


# Vref,pxb

## New Bias Point

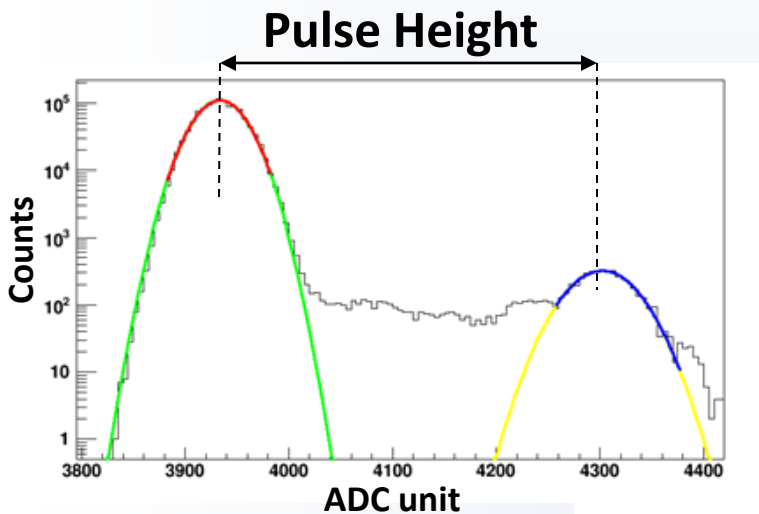


### Remainders Map, New Bias Point



1 mV =  $64.7 \times 10^{-3}$  ph (@12keV), CDS gain high

# Data Acquisition with Photons



Mo @ 17.5 keV

Writing Time

$\Delta(\text{WT}) = 12.5\text{ns}$ , Scan from 50 to 150 ns

Vref,cds

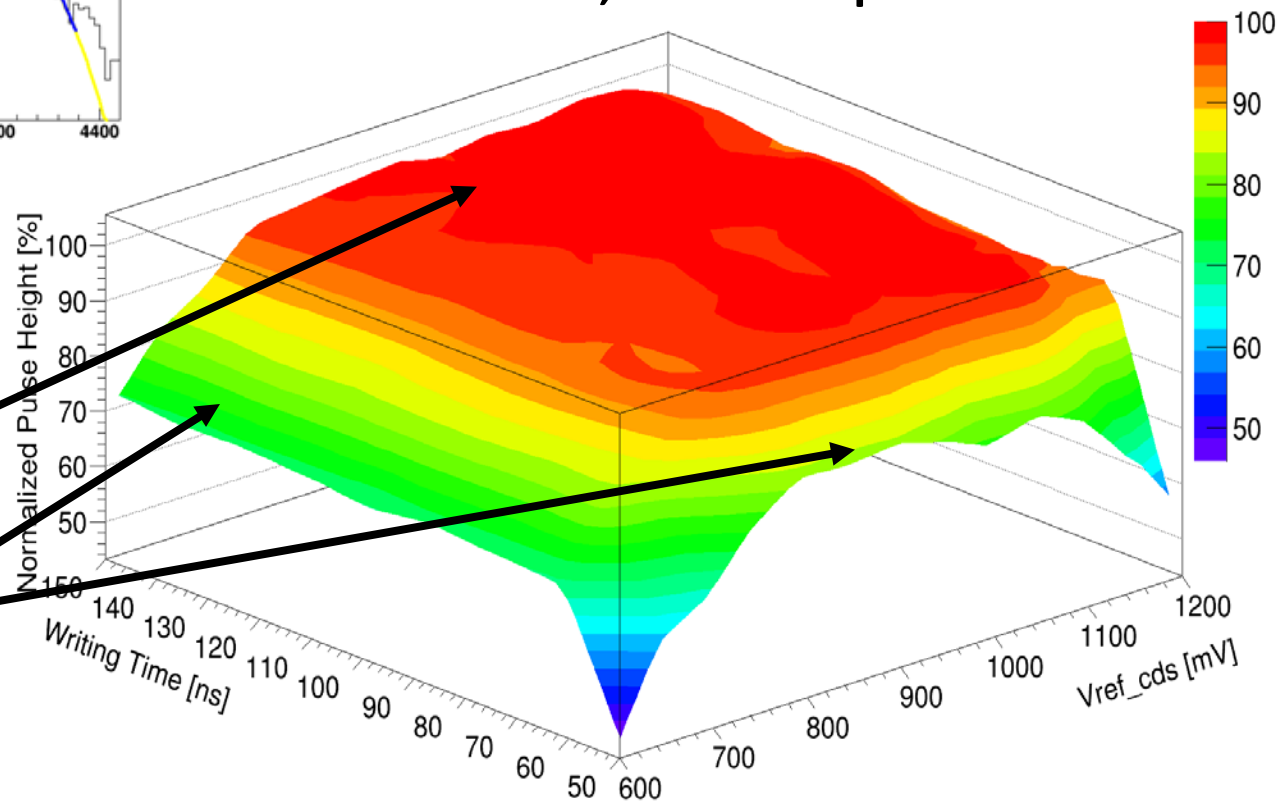
Voltage step  $\Delta V = 50\text{mV}$ , Scan from 600 to 1200 mV

AGIPD10, 1 Pixel Map

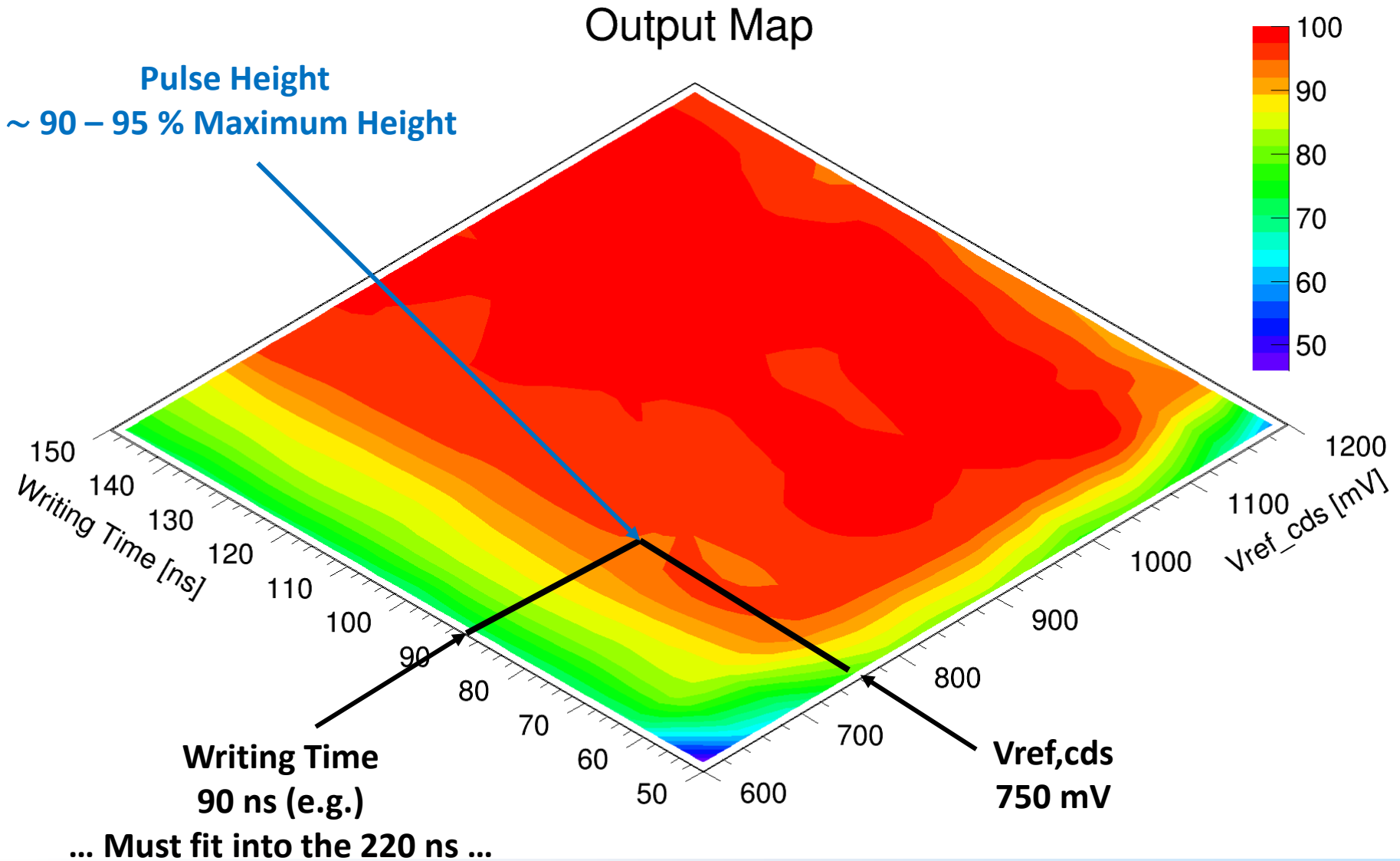
Noise =  $286 \pm 9$  el.

~ Complete Writing

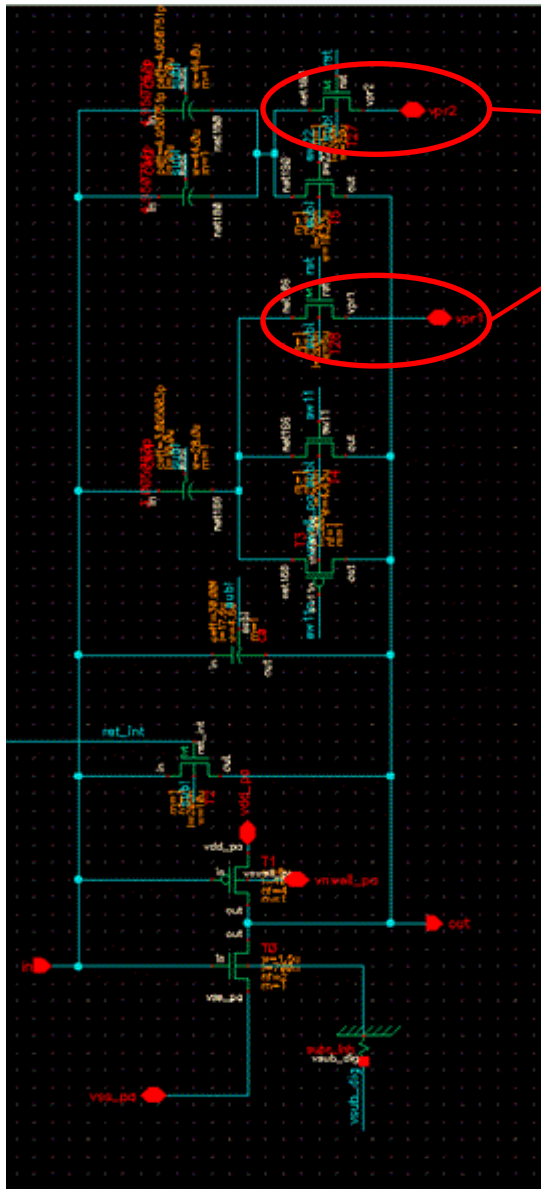
Incomplete Writing



# Vref,cds – Writing Time

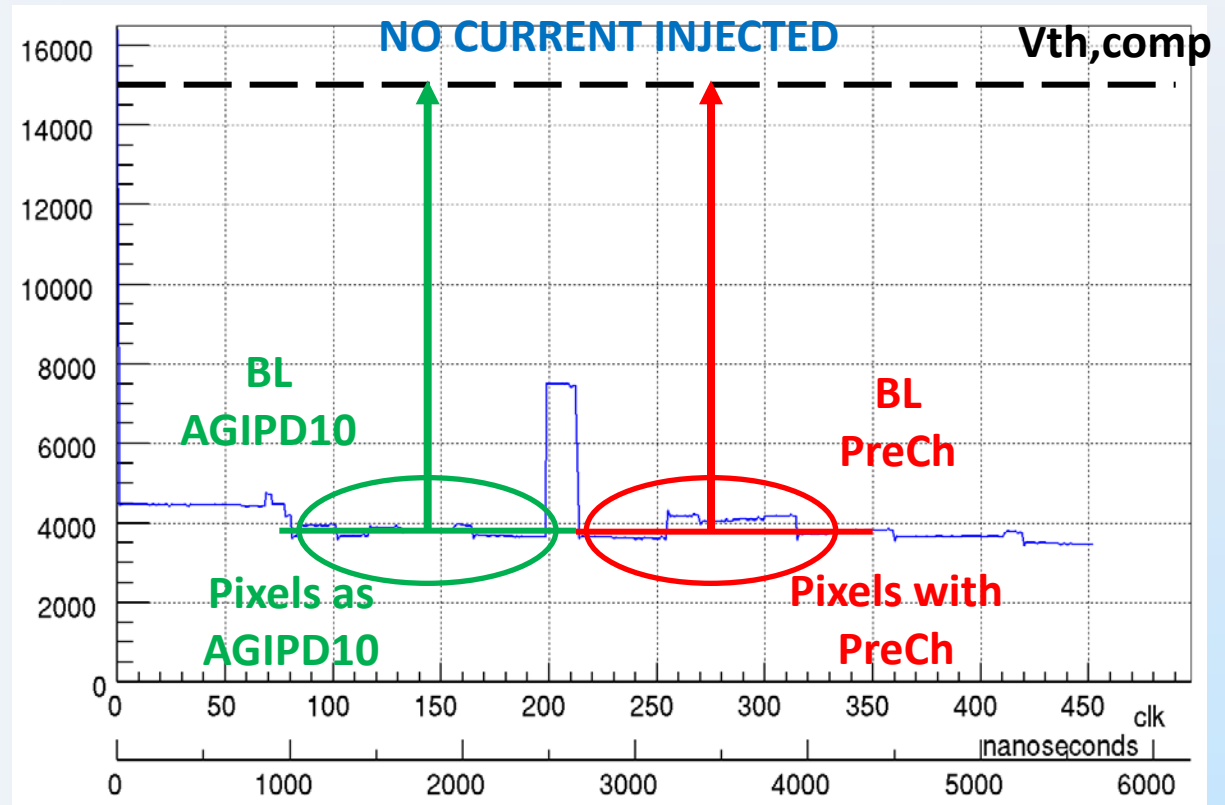


# Ongoing... AGIPD05... DR Enhancement...



Possibility to Pre-Charge the C of the Medium and Low Gain to a fixed voltage  $V_{pr1}$  and  $V_{pr2}$  adjustable by means of 2 potentiometers

## HIGH GAIN










## New Optimized Settings

- $V_{ref,cob} = 875mV$
- $V_{com,cob} = 750mV$
- $V_{ref,pxb} = 850mV$
- $V_{ref,cds} - \text{Int Time (Writing Time)}$   **Can be chosen according to the pulse height needed**
- No Critical Influence of the Output CM on the linearity
- Ongoing measurements on Pixels with PreCharge (AGIPD05) to evaluate the Enhancement of DR and the Impact on the Noise